Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/644,161	CHAN, VI CHI
Examiner	Art Unit
Joseph P. Hirl	2129

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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